

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

SSM3K01F

High Speed Switching Applications

- Small package
- Low on resistance: $R_{on} = 120 \text{ m}\Omega$ (max) ($V_{GS} = 4 \text{ V}$)
 $R_{on} = 150 \text{ m}\Omega$ (max) ($V_{GS} = 2.5 \text{ V}$)
- Low gate threshold voltage: $V_{th} = 0.6\sim 1.1 \text{ V}$ ($V_{DS} = 3 \text{ V}$, $I_D = 0.1 \text{ mA}$)

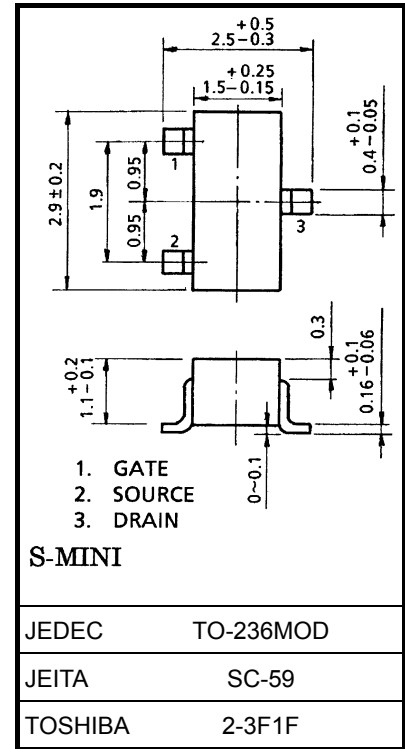
Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$)

| Characteristics | | Symbol | Rating | Unit |
|---------------------------|-------|-----------|---------------|------------------|
| Drain-source voltage | | V_{DS} | 30 | V |
| Gate-source voltage | | V_{GS} | ± 10 | V |
| Drain current | DC | I_D | 1.3 | A |
| | Pulse | I_{DP} | 2.6 | |
| Drain power dissipation | | P_D | 200 | mW |
| Channel temperature | | T_{ch} | 150 | $^\circ\text{C}$ |
| Storage temperature range | | T_{stg} | $-55\sim 150$ | $^\circ\text{C}$ |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

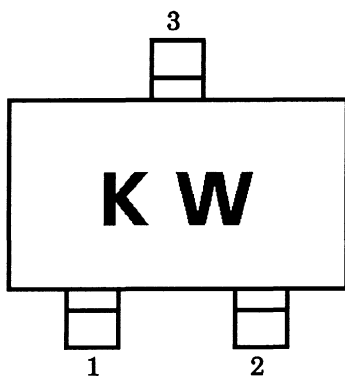
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Unit: mm

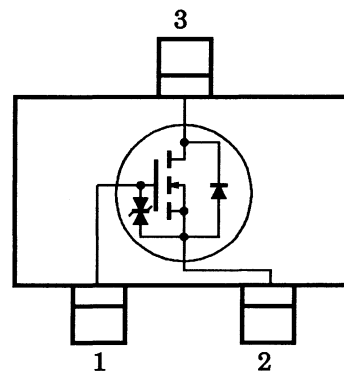


Weight: 0.012 g (typ.)

Marking



Equivalent Circuit



Handling Precaution

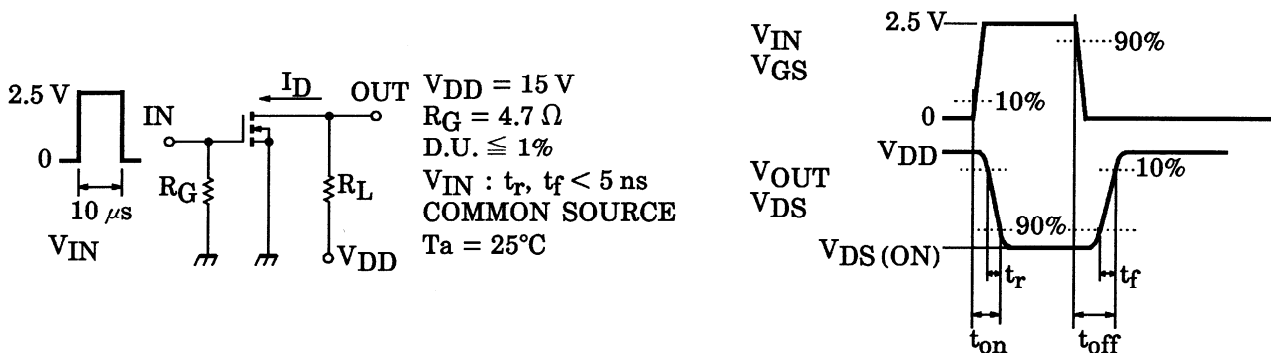
When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

Electrical Characteristics (Ta = 25°C)

| Characteristics | | Symbol | Test Condition | Min | Typ. | Max | Unit |
|--------------------------------|---------------|---------------|---|-----|------|---------|---------------|
| Gate leakage current | | I_{GSS} | $V_{GS} = \pm 10\text{ V}, V_{DS} = 0$ | — | — | ± 5 | μA |
| Drain-source breakdown voltage | | $V_{(BR)DSS}$ | $I_D = 1\text{ mA}, V_{GS} = 0$ | 30 | — | — | V |
| Drain cut-off current | | I_{DSS} | $V_{DS} = 30\text{ V}, V_{GS} = 0$ | — | — | 1 | μA |
| Gate threshold voltage | | V_{th} | $V_{DS} = 3\text{ V}, I_D = 0.1\text{ mA}$ | 0.6 | — | 1.1 | V |
| Forward transfer admittance | | $ Y_{fs} $ | $V_{DS} = 3\text{ V}, I_D = 0.65\text{ A}$ (Note) | 2.0 | — | — | S |
| Drain-source ON resistance | | $R_{DS(ON)}$ | $I_D = 0.65\text{ A}, V_{GS} = 4\text{ V}$ (Note) | — | 85 | 120 | m Ω |
| | | | $I_D = 0.65\text{ A}, V_{GS} = 2.5\text{ V}$ (Note) | — | 115 | 150 | |
| Input capacitance | | C_{iss} | $V_{DS} = 10\text{ V}, V_{GS} = 0, f = 1\text{ MHz}$ | — | 152 | — | pF |
| Reverse transfer capacitance | | C_{rss} | $V_{DS} = 10\text{ V}, V_{GS} = 0, f = 1\text{ MHz}$ | — | 41 | — | pF |
| Output capacitance | | C_{oss} | $V_{DS} = 10\text{ V}, V_{GS} = 0, f = 1\text{ MHz}$ | — | 102 | — | pF |
| Switching time | Turn-on time | t_{on} | $V_{DD} = 15\text{ V}, I_D = 0.5\text{ A}, V_{GS} = 0 \sim 2.5\text{ V}, R_G = 4.7\ \Omega$ | — | 45 | — | ns |
| | Turn-off time | t_{off} | | — | 69 | — | |

Note: Pulse test

Switching Time Test Circuit

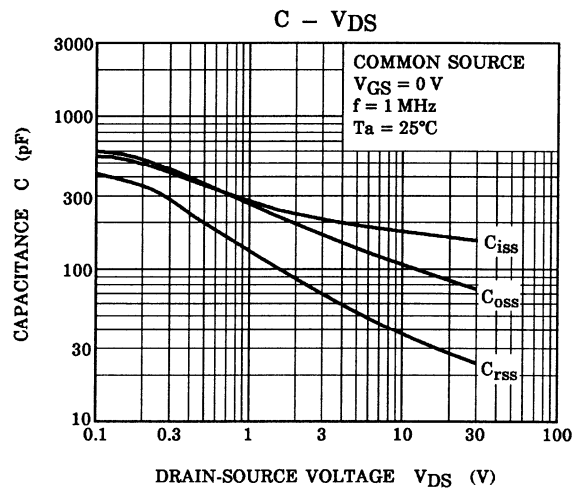
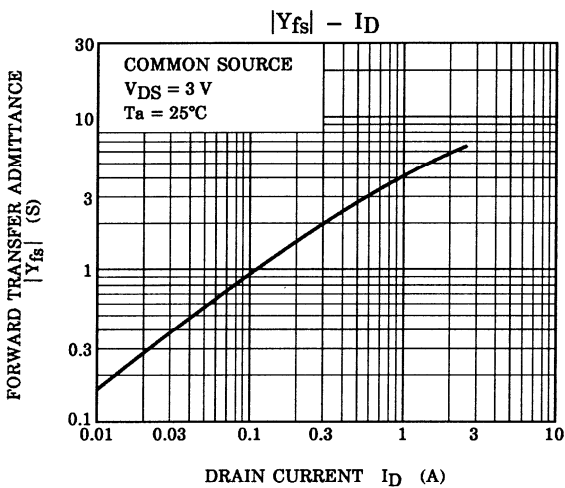
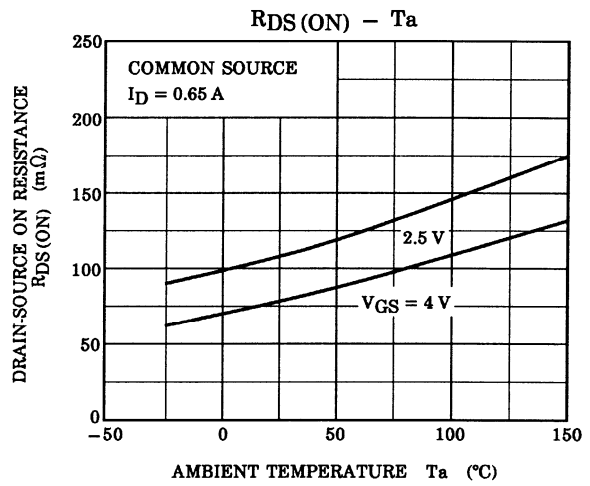
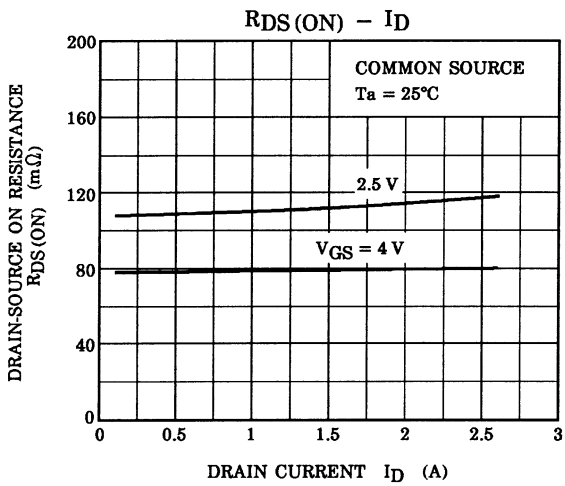
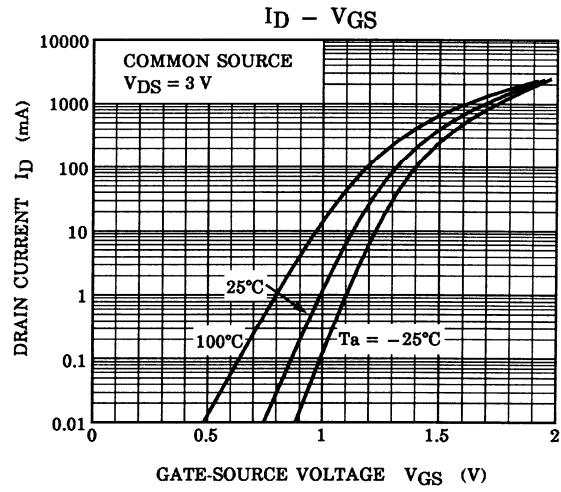
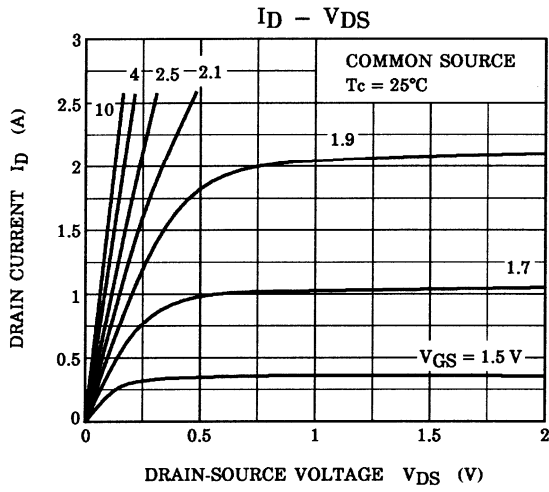


Precaution

V_{th} can be expressed as voltage between gate and source when low operating current value is $I_D = 100\ \mu\text{A}$ for this product. For normal switching operation, $V_{GS(ON)}$ requires higher voltage than V_{th} and $V_{GS(off)}$ requires lower voltage than V_{th} .

(Relationship can be established as follows: $V_{GS(off)} < V_{th} < V_{GS(ON)}$)

Please take this into consideration for using the device.



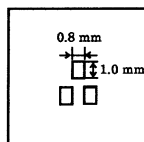
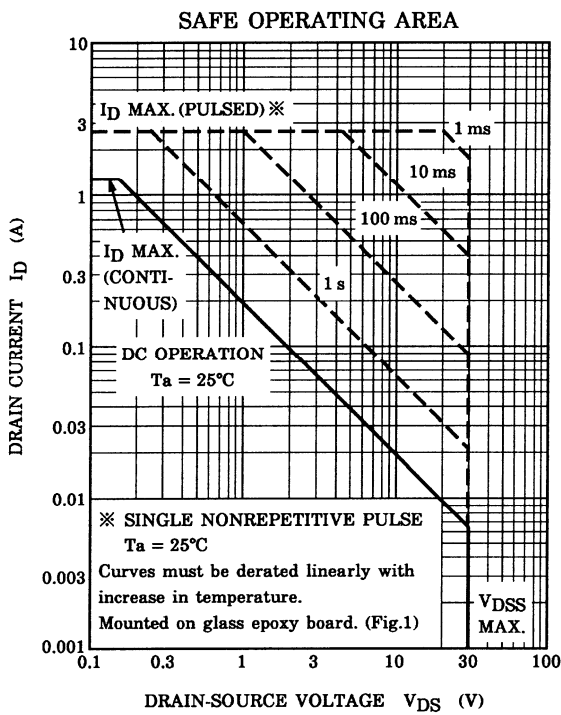
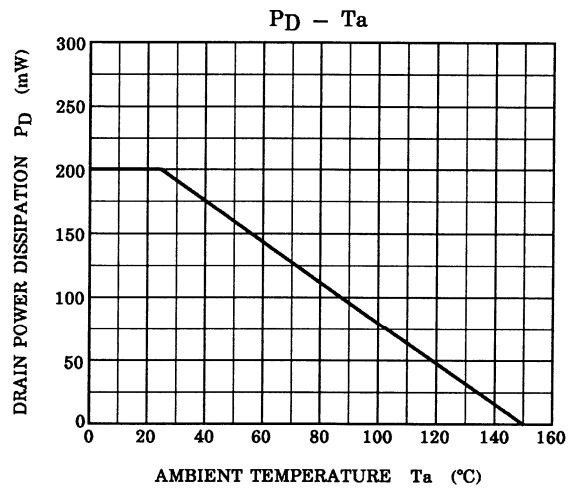
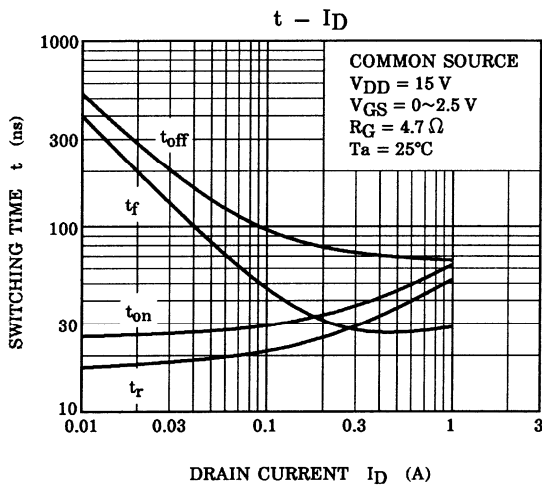


Figure 1 25.4 mm × 25.4 mm × 1.6 t (a Cu pad of 0.8 mm² area)

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